

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/868,749	VAN DEN HOVEN ET AL.	
Examiner	Art Unit	
Kieu D. Vu	2173	

	SEARCHED					
Class	Subclass	Date	Examiner			
715	723	7/31/2006	κv			
715	730	7/31/2006	ΚV			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
USPAT-USPGPUB		8/1/2006	KV		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East search (USPAT USPGPUB EPO JPO DERWENT IBM_TDB USOCR) (See Search History Printout)	7/31/2006	ΚV		
715/731 715/732 715/835 715/838 715/810 715/769	7/31/2006	κv		
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